

Notice of References Cited		Application/Control No. 10/577,902	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
		Examiner Vu Nguyen	Art Unit 4171	Page 1 of 1

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*	B	US-2002/0128351 A1	09-2002	Kiguchi et al.	523/161
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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